


<b>Search Notes</b>  	<b>Application/Control No.</b>  10561414	<b>Applicant(s)/Patent Under Reexamination</b>  BORTHWICK ET AL.
	<b>Examiner</b>  Nolan, Ph.D., Jason M	<b>Art Unit</b>  1626

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Search (eDAN) - reviewed for double patenting	9/19/07	JMN
STN Structure Search (Registry/Caplus) - printout attached	9/18/07	JMN
Abstract, Oath, Spec, Priority Papers and 371 Docs reviewed	9/18/07	JMN
IDS Considered	9/19/07	JMN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner